IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re: Application Ser. No. 09/768,372

Art Unit 2827

Filed 1/23/01

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Inventors Blackshear et al

Atty Dkt No YOR919980001US2 Ctru/Du

For: STRESS ACCOMMODATION IN ELECTRONIC DEVICE INTERCONNECT TECHNOLOGY FOR MILLIMETER CONTACT LOCATIONS

Response to 5/9/02 Office Action

Assistant Commissioner for Patents U.S. Patent and Trademark Office Washington, D.C. 20231 Sir:

In response to the 5/9/02 office action kindly amend this application as follows.

TECHNOLOGY JEWIER 2800

In the claims:

Claim 1 is to be amended by erasing on line 12 the cross hatched word "operable" and replacing it with the underlined expression - so positioned - as follows.

- 1. In an array of conductive joints between signal pads on a surface of an integrated circuit 1
- member of a material having a first thermal responsiveness and corresponding
- contacts on an aligned wiring support member of a material having a second thermal
- responsiveness,
- the improvement comprising: 5
- an interface having first and second portions,
- said first portion of said interface containing an array of elongated conductive joint 7
- members each having a contacting area made up of a length contacting dimension and 8
- a width contacting dimension and with said length contacting dimension being longer 9